# THOMSON-CSF SEMICONDUCTEURS SPECIFIQUES TSPC2605



# INTEGRATED SECONDARY CACHE MODULE FOR PowerPC<sup>™</sup> MICROPROCESSORS

# DESCRIPTION

The TSPC2605 is a single chip, 256KB integrated look–aside cache with copy–back capability designed for PowerPC applications (TSPC603e). Using 0.38  $\mu$ m technology along with standard cell logic technology, the TSPC2605 integrates data, tag, host interface, and least recently used (LRU) memory with a cache controller to provide a 256KB, 512KB, or 1 MB Level 2 cache with one, two, or four chips on a 64–bit PowerPC bus.

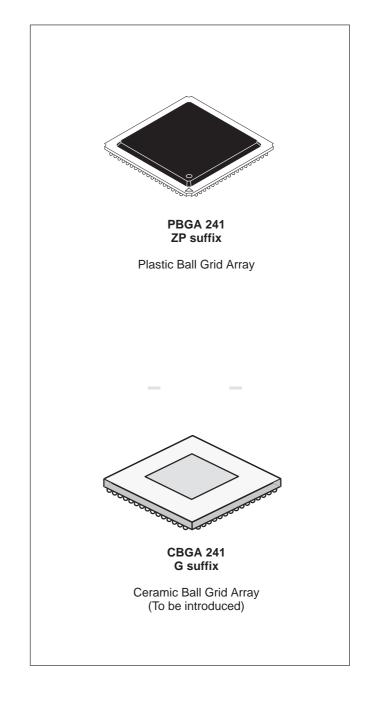
## **MAIN FEATURES**

- Single Chip L2 Cache for PowerPC
- 66 MHz Zero Wait State Performance (2–1–1–1 Burst)
- Four–Way Set Associative Cache Design
- 32K x 72 Data Memory Array
- 8K x 18 Tag Array
- Address Parity Support
- LRU Cache Control Logic
- Copy–Back or Write–Through Modes of Operation
- Copy–Back Buffer for Improved Performance
- Single 3.3 V Power Supply
- 5 V Tolerant I/O
- 1, 2, or 4 Chip Cache Solution (256KB, 512KB, or 1MB)
- Single Clock Operation
- Compliant with IEEE Standard 1149.1 Test Access Port (JTAG)
- Supports up to 4 Processors in a Shared Cache Configuration

# **SCREENING / QUALITY / PACKAGING**

This product is manufactured in full compliance with :

- MIL-STD-883 class B or According to TCS standards
- Upscreening based upon TCS standards
- Full military temperature range (T<sub>c</sub> = -55°C, Tc = +125°C) Industrial temperature range (T<sub>c</sub> = -40°C, T<sub>c</sub> = +110°C)
- Power Supply = 3.3 V ± 5 %.
- 241-pin PBGA and CBGA packages



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THOMSON-CSF SEMICONDUCTEURS SPECIFIQUES

# A. GENERAL DESCRIPTION

# 1. PIN ASSIGNMENT

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19
A	Δ	$\frac{\circ}{ABB}$	$\frac{O}{L2 BG}$	O DH20	O DH19	O DH17	O DH31	O DH29	O DH27	O DH26	O DL16	O DL19	O DL22	O DP6	O DL25	O DL27	O DL29	O DL30	
В		O CFG4	$\frac{O}{L2}$	O DH23	O DH21	O DH18	O DH16	O DH30	O DH28	O DH25	O DL17	O DL20	O DL23	O DL24	O DL26	O DL28	O DL31	O DP7	$\frac{O}{APE}$
С	BG O FDN	$\begin{array}{c} 0 \\ \hline \hline CPU3 \\ \hline BR \end{array}$	IISS INF O CPU3 DBG	V <sub>DD</sub>	O DP2	O DH22	$_{V_{SS}}^{\circ}$	O DP3	$_{V_{SS}}^{\circ}$	O DH24	O DL18	O DL21	$\overset{\mathbb{O}}{v_{ss}}$	$_{V_{SS}}^{\odot}$	• V <sub>DD</sub>	• V <sub>DD</sub>	O AP3	O AP2	O AP1
D	O L2 BR	0	O CPU2 DBG				$\overset{O}{V_{SS}}$	$\overset{O}{V_{SS}}$	• V <sub>DD</sub>	• V <sub>DD</sub>	• V <sub>DD</sub>	$^{\circ}_{V_{SS}}$	$\overset{\mathbb{O}}{V_{SS}}$				O AP0	O L2 FLUSH	$\frac{O}{L2}{CI}$
Е	$\frac{O}{TA}$	O L2 DBG	0														O CFG3	0	O GBL
F	$\frac{O}{CPU}$	$\frac{O}{L2}$	O NC														O TSIZ1	O TSIZ0	O TSIZ2
G	ARTRY	CLAIM CI	AAC	$\stackrel{O}{V_{SS}}$												$\overset{O}{V_{SS}}$	$\overset{\bigcirc}{v_{SS}}$	$\stackrel{O}{V_{SS}}$	O A13
Н	O TEA	$\frac{O}{CPU}{BR}$	$\frac{\overline{k}}{WT}$	○ V <sub>SS</sub>				• V <sub>DD</sub>	• V <sub>DD</sub>	• V <sub>DD</sub>	$^{\circ}_{V_{SS}}$	0 V <sub>SS</sub>				© V <sub>SS</sub>	0 A14	0 A15	O A16
J	O HRESE			V <sub>DD</sub>				• V <sub>DD</sub>	• V <sub>DD</sub>	© V <sub>SS</sub>	$^{\circ}_{V_{SS}}$	© V <sub>SS</sub>				• V <sub>DD</sub>	0 A19	0 A18	O A17
К	O TT1	O TT0	O TBST	• V <sub>DD</sub>				• V <sub>DD</sub>	O V <sub>SS</sub>	© V <sub>SS</sub>	$^{\circ}_{\rm V_{SS}}$	• V <sub>D</sub>				• V <sub>DD</sub>	O A20	O A22	O A21
L	O TT4	O TT2	$\frac{O}{TS}$	• V <sub>DD</sub>				© Vss	○ V <sub>SS</sub>	© V <sub>SS</sub>	• V <sub>DD</sub>	D V <sub>DD</sub>				• V <sub>DD</sub>	O A25	0 A24	O A23
М	O TT 3	$\frac{O}{CPU}{\overline{BG}}$	O CLK	© V <sub>SS</sub>				0 V <sub>SS</sub>	O V <sub>SS</sub>	• V <sub>DD</sub>	• V <sub>DD</sub>	• V <sub>DD</sub>				O V <sub>SS</sub>	O A28	0 A27	O A26
Ν	O SRESET	$\frac{O}{L2}$ $\overline{L}$	O 2 UPDA INH	O ATEV <sub>SS</sub>												$\overset{\mathbb{O}}{\mathrm{V}_{\mathrm{SS}}}$	0 A31	O A30	O A29
Р	O TDI	О ТСК	0														O A10	0 A11	O A12
R	O TDO	O TRST	O NC														O A7	0 A8	0 A9
Т	$\frac{O}{CPU4}{\overline{BG}}$	$\frac{O}{CPU4}{\overline{DBG}}$	• V <sub>DD</sub>				$\overset{\mathbb{O}}{\mathrm{V}_{\mathrm{SS}}}$	$\overset{\bigcirc}{\mathrm{V}_{\mathrm{SS}}}$	• V <sub>DD</sub>	• V <sub>DD</sub>	• V <sub>DD</sub>	$^{\circ}_{V_{SS}}$	$\overset{\bigcirc}{\mathrm{V}_{\mathrm{SS}}}$				• V <sub>DD</sub>	O A5	O A6
U	$\frac{O}{CPU4}{\overline{BR}}$	O CFG0	• V <sub>DD</sub>	• V <sub>DD</sub>	$\overset{O}{V_{SS}}$	○ V <sub>SS</sub>	O V <sub>SS</sub>		O DH10		O DL4	O V <sub>SS</sub>	$\overset{\bigcirc}{\mathrm{V}_{\mathrm{SS}}}$	$\overset{\bigcirc}{\mathrm{V}_{\mathrm{SS}}}$	• V <sub>DD</sub>	O DP5	• V <sub>DD</sub>	O A3	O A4
V	O CFG2	O CFG1	O DH7	O DH5	O DH3	O DH1	O DP1		O DH11		O DL3	O DL6	O DP4	O DL10		O DL14		O A1	O A2
W		O DP0	O DH6	O DH4	O DH2	O DH0	O DH15	O DH12	O DH9	O DH8	O DL2	O DL5	O DL7	O DL8	O DL9	O DL11	O DL13	O A0	

TOP VIEW (X-RAY VIEW)

# 2. SIGNAL DESCRIPTION

Pin Locations	Pin Name	Туре	Description
19G, 17H – 19H, 17J – 19J, 17K – 19K, 17L – 19L,17M – 19M, 17N – 19N,17P – 19P, 17R – 19R,18T, 19T, 18U, 19U,18V, 19V, 18W *	A0 – A31	I/O	Address inputs from processor. Can also be outputs for processor snoop addresses. A0 is the MSB. A31 is the LSB.
3G	AACK	I/O	Address acknowledge input/output.
2A	ABB	I/O	Used as an input to qualify bus grants. Driven as an output during address tenure initiated by the TSPC2605.
17C – 19C, 17D <b>*</b>	AP0 – AP3	I/O	Address parity.
19B	APE	0	Address parity error. When an address parity error is detected, $\overline{\text{APE}}$ will be driver low one clock cycle after the assertion of TS then High–Z following clock cycle.
18E	APEN	I	Address parity enable. When tied low, enables address parity bits and the address parity error bit.
1G	ARTRY	I/O	Address retry status I/O. Generated when a read or write snoop to a dirty processor cache line has occurred.
2U 2V 1V 17E 2B	CFG0 CFG1 CFG2 CFG3 CFG4	1	Configuration inputs. These must be tied to either $V_{DD}$ or $V_{SS}$ .CFG0CFG1CFG200010512KB; A26 = 0011101MB; A25 - A26 = 00101101MB; A25 - A26 = 01111MB; A25 - A26 = 10111111111CFG3Snoop Data Tenure Selector0Supports snoop data tenure1Does not support snoop data tenure1Does not support snoop data tenure1Enable0Disable AACK driver1Enable AACK driver
2G	CI	I/O	Cache inhibit I/O.
3M	CLK	I	Clock input. This must be the same as the processor clock input.
2M	CPU BG	I	CPU bus grant input.
3E	CPU2 BG	I	TSPC2605 logically ORs this signal with CPU BG. Used in multiprocesso configuration as the second CPU BG.
1B	CPU3 BG	I	TSPC2605 logically ORs this signal with CPU BG. Used in multiprocessor configuration as the third CPU BG.
1T	CPU4 BG	I	TSPC2605 logically ORs this signal with $\overline{\text{CPU BG}}$ . Used in multiprocessor configuration as the fourth $\overline{\text{CPU BG}}$ .
2H	CPU BR	I	CPU bus request input.
2D	CPU2 BR	I	TSPC2605 logically ORs this signal with CPU BR. Used in multiprocessor configuration as the second CPU BR.
2C	CPU3 BR	I	TSPC2605 logically ORs this signal with CPU BR. Used in multiprocessor configuration as the third CPU BR.
1U	CPU4 BR	I	TSPC2605 logically ORs this signal with $\overline{\text{CPU BR}}$ . Used in multiprocessor configuration as the fourth $\overline{\text{CPU BR}}$ .
1F	CPU DBG	I	CPU data bus grant input from arbiter.
3D	CPU2 DBG	I	TSPC2605 logically ORs this signal with CPU DBG. Used in multiprocessor configuration as the second CPU DBG.
3C	CPU3 DBG	I	TSPC2605 logically ORs this signal with CPU DBG. Used in multiprocessor configuration as the third CPU DBG.

\* See pin diagram (page 2) for specific pin assignment of these bus signals.

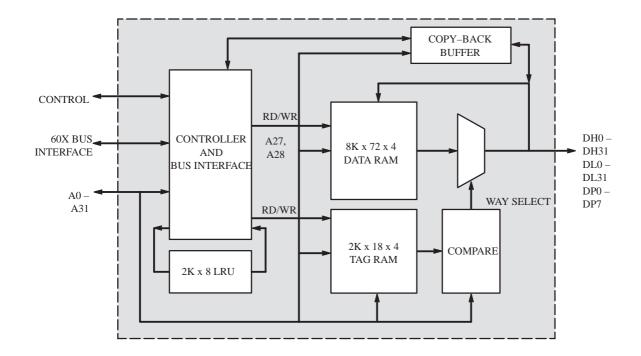
Pin Locations	Pin Name	Туре	Description
2T	CPU4 DBG	I	TSPC2605 logically ORs this signal with $\overline{\text{CPU DBG}}$ . Used in multiprocesso configuration as the fourth $\overline{\text{CPU DBG}}$ .
11A – 13A, 15A – 18A,11B – 17B, 11C, 12C, 10U,11U, 10V – 12V,	DL0 – DL31	I/O	Data bus low input and output. DL0 is the MSB. DL31 is the LSB.
14V – 17V, 11W – 17W <sup>*</sup>			
4A - 10A, 4B - 10B, 6C,10C, 8U, 9U, 3V - 6V,8V, 9V, 3W -10W *	DH0 – DH31	I/O	Data bus high input and output. DH0 is the MSB. DH31 is the LSB.
2J	DBB	I/O	Data bus busy. Used as input when processor is master, driven as an output after a qualified $L2$ DBG when TSPC2605 is the bus master. Note: To operate in Fas L2 mode, this pin must be tied high.
14A, 18B, 5C, 8C,16U, 7V, 13V, 2W *	DP0 – DP7	I/O	Data bus parity input and output.
1C	FDN	I/O	Flush done I/O used for communication between other TSPC2605 devices. Mus be tied together between all TSPC2605 parts along with a pullup resistor.
19E	GBL	0	Global transaction. Always negated when MPC2604 is bus master.
1J	HRESET	I	Hard reset input from processor bus. This is an asynchronous input that must be low for at least 16 clock cycles to ensure the TSPC2605 is properly reset. Fo proper initialization, TRST must be asserted before HRESET is asserted.
3A	L2 BG	I	Bus grant input from arbiter.
1D	L2 BR	I/O	Bus request I/O. Normally used as an output.
19D	L2 CI	I	Secondary cache inhibit sampled, after assertion of TS. Assertion prevent linefill.
2F	L2 CLAIM	0	L2 cache claim output. Used to claim the bus for processor initiated memor operations that hit the L2 cache. L2 CLAIM goes true (low) before the rising edg of CLK following $\overline{\text{TS}}$ true. Because this output is not always driven, a pullu resistor may be necessary to ensure proper system functioning.
2E	L2 DBG	I	Data bus grant input. Comes from system arbiter, used to start data tenure for bus operations where TSPC2605 is the bus master.
18D	L2 FLUSH	I	Causes cache to write back dirty lines and clears all tag valid bits.
3B	L2 MISS INH	I	Prevents line fills on misses when asserted.
2N	L2 TAG CLR	I	Invalidates all tags and holds cache in a reset condition.
3N	L2 UPDATE INH	I	Cache disable. When asserted, the TSPC2605 will not respond to signals on th local bus and internal states do not change.
3J	PWRDN	I	Provides low power mode. Prevents address and data transitions into the RAI array. TSPC2605 becomes active 4 $\mu$ s after deassertion. Clock must b externally disabled.
1N	SRESET	I	Soft reset input from processor bus.
1E	TA	I/O	Transfer acknowledge status I/O from processor bus.
ЗК	TBST	I/O	Transfer burst status I/O from processor bus. Used to distinguish betwee burstable and non-burstable memory operations.
2P	тск	I	Test clock input for IEEE 1149.1 boundary scan (JTAG).
1P	TDI	I	Test data input for IEEE 1149.1 boundary scan (JTAG).
1R	TDO	0	Test data output for IEEE 1149.1 boundary scan (JTAG).
1H	TEA	I	Transfer error acknowledge status input from processor bus.
3P	TMS	1	Test mode select for IEEE 1149.1 boundary scan (JTAG).

 $^{\ast}$  See pin diagram (page 2) for specific pin assignment of these bus signals.

Pin Locations	Pin Name	Туре	Description
2R	TRST	I	Test reset input for IEEE 1149.1 boundary scan (JTAG). If JTAG will not be used, TRST should be tied low.
3L	TS	I/O	Transfer start I/O from processor bus (can also come from any bus master on the processor bus). Signals the start of either a processor or bus master cycle.
17F – 19F *	TSIZ0-TSIZ2	I/O	Transfer size I/O from processor bus.
1K, 2K, 1L, 2L, 1M *	TT0-TT4	I/O	Transfer type I/O from processor bus.
ЗН	WT	I/O	Write through status input from processor bus. When tied to ground, the TSPC2605 will operate in write-through mode only (no copy-back).
4C, 15C, 16C, 9D – 11D,8H – 10H, 4J, 8J, 9J, 16J, 4K, 8K, 12K, 16K, 4L, 11L, 12L, 16L, 10M – 12M, 3T, 9T – 11T, 17T, 3U, 4U, 15U, 17U	V <sub>DD</sub>	Supply	Power supply: 3.3 V $\pm$ 5%.
7C, 9C, 13C, 14C, 7D, 8D, 12D, 13D, 4G, 16G – 18G, 4H, 11H, 12H, 16H, 10J – 12J, 9K – 11K, 8L – 10L, 4M, 8M, 9M, 16M, 4N, 16N, 7T, 8T, 12T, 13T, 5U – 7U, 12U – 14U	V <sub>SS</sub>	Supply	Ground.
3F, 3R	NC	—	No connection: There is no connection to the chip.

\* See pin diagram (page 2) for specific pin assignment of these bus signals.

# 3. SIMPLIFIED BLOCK DIAGRAM



# **B. DETAILED SPECIFICATIONS**

# 1. SCOPE

This drawing describes the specific requirements for the microprocessor TSPC2605, in compliance with MIL-STD-883 class B or TCS standard screening.

# 2. APPLICABLE DOCUMENTS

1) MIL-STD-883 : Test methods and procedures for electronics.

2) MIL-PRF-38535 appendix A : General specifications for microcircuits.

# 3. REQUIREMENTS

# 3.1. General

The microcircuits are in accordance with the applicable documents and as specified herein.

# 3.2. Design and construction

#### 3.2.1.Terminal connections

Depending on the package, the terminal connections shall be is shown in § A.1 PIN ASSIGNMENT.

#### 3.2.2.Lead material and finish

Lead material and finish shall be as specified in MIL-STD-1835 (see enclosed § 8)

#### 3.2.3.Hermetic Package

The macrocircuits are packaged in 241 pin ceramic and plastic ball grid array packages (see § 8.1 and 8.2) The precise case outlines are described at the end of the specification (§ 8.1 and 8.2) and into MIL-STD-1835.

# 3.3. Absolute maximum ratings

Rating	Symbol	Value	Unit
Power Supply Voltage	V <sub>DD</sub>	– 0.5 to + 4.6	V
Voltage Relative to V <sub>SS</sub>	V <sub>in</sub> , V <sub>out</sub>	– 0.5 to V <sub>DD</sub> + 0.5	V
Output Current (per I/O)	l <sub>out</sub>	± 20	mA
Power Dissipation (Note 2)	PD	—	W
Temperature Under Bias	T <sub>bias</sub>	– 10 to + 85	°C
Operating Temperature	T <sub>c</sub>	-55 to +125	°C
Storage Temperature	T <sub>stg</sub>	– 55 to +125	°C

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high–impedance circuit.

This BiCMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established.

NOTES:

 Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMEND OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

2. Power dissipation capability is dependent upon package characteristics and use environment. See Package Thermal Characteristics.

# 3.4. Thermal Characteristics

### 3.4.1.PBGA Package

Rating	Symbol	Max	Unit
Thermal Resistance Junction to Ambient (Still Air, Test Board with Two Internal Planes)	$R_{\thetaJA}$	26.5	°C/W
Thermal Resistance Junction to Ambient (200 lfpm, Test Board with Two Internal Planes)	$R_{\thetaJA}$	23.2	°C/W
Thermal Resistance Junction to Board (Bottom)	R <sub>θJB</sub>	15.9	°C/W
Thermal Resistance Junction to Case (Top)	R <sub>θJC</sub>	6.6	°C/W

# 3.4.2.CBGA Package

Rating	Symbol	Max	Unit
Thermal Resistance Junction to Ambient (Still Air, Test Board with Two Internal Planes)	$R_{\thetaJA}$	TBD	°C/W
Thermal Resistance Junction to Ambient (200 lfpm, Test Board with Two Internal Planes)	$R_{\thetaJA}$	TBD	°C/W
Thermal Resistance Junction to Board (Bottom)	$R_{\theta JB}$	TBD	°C/W
Thermal Resistance Junction to Case (Top)	$R_{\theta JC}$	TBD	°C/W

# 3.5. Marking

The document where are defined the marking are identified in the related reference documents. Each microcircuit are legible and permanently marked with the following information as minimum :

- Thomson logo,
- Manufacturer's part number,
- Class B identification if applicable,
- Date-code of inspection lot,
- ESD identifier if available,
- Country of manufacturing.

# 4. ELECTRICAL CHARACTERISTICS

# 4.1. <u>Recommanded Operating Conditions</u>

Parameter	Symbol	Min	Тур	Мах	Unit
Supply Voltage (Operating Voltage Range)	V <sub>DD</sub>	3.135	3.3	3.465	V
Input High Voltage	V <sub>IH</sub>	2.0	_	5.5	V
Input Low Voltage	V <sub>IL</sub>	- 0.5*	_	0.8	V

\*  $V_{IL}(min)$  = – 2.0 V ac (pulse width  $\leq$  20 ns).

# 4.2. DC Characteristics

Parameter	Symbol	Min	Max	Unit
Input Leakage Current (All Inputs, $V_{in} = 0$ to $V_{DD}$ )	I <sub>lkg(I)</sub>	—	± 1.0	μA
Output Leakage Current (High-Z State, V <sub>out</sub> = 0 to V <sub>DD</sub> )	I <sub>lkg(O)</sub>	—	± 1.0	μA
AC Supply Current ( $I_{out} = 0$ mA, All inputs = $V_{IL}$ or $V_{IH}$ , $V_{IL} = 0$ V, and $V_{IH} \ge 3.0$ V, Cycle Time = 15 ns, max value assumes a constant burst read hit, with 100% bus utilization, and 100% hit rate)	I <sub>CCA</sub>	—	720	mA
AC Quiescent Current (I <sub>out</sub> = 0 mA, All inputs = V <sub>IL</sub> or V <sub>IH</sub> , V <sub>IL</sub> = 0 V and V <sub>IH</sub> $\ge$ 3.0 V, Cycle Time = 15 ns, All Other Inputs DC)	Ι <sub>Q</sub>	_	195	mA
Output Low Voltage (I <sub>OL</sub> = + 8.0 mA)	V <sub>OL</sub>	—	0.4	V
Output High Voltage (I <sub>OH</sub> = - 4.0 mA)	V <sub>OH</sub>	2.4	_	V

# 4.3. Capacitance

Parameter	Symbol	Тур	Max	Unit
Input Capacitance	C <sub>in</sub>	4	6	рF
Output Capacitance	C <sub>out</sub>	6	8	pF
Input/Output Capacitance	C <sub>I/O</sub>	8	10	pF

\* f = 1.0 MHz, dV = 3.0 V,  $T_A$  = 25°C, Periodically Sampled Rather Than 100% Tested

# 4.4. AC Operating Conditions and Characteristics (T<sub>C</sub> = -55 to +125°C, Unless Otherwise Noted)

Input Timing Measurement Reference Level 1.5 V	/
Input Pulse Levels 0 to 3.0 \	/
Input Rise/Fall Time 2 ns	s

#### 4.4.1.AC Clock Specification

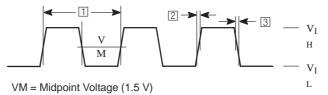
	Timing	TSPC2605-66			
Parameter	Reference	Min	Max	Unit	Notes
Frequency of Operation		—	66.67	MHz	
Clock Cycle Time	1	15	—	ns	
Clock Rise and Fall Time	2, 3	1.0	2.0	ns	1, 2
Clock Duty Cycle Measured at 1.5 V		40	60	%	
Clock Short-Term Jitter (Cycle to Cycle)		_	± 150	ps	1

NOTES:

1. This parameter is sampled and not 100% tested.

2. Rise and fall times for the clock input are measured from 0.4 to 2.4 V.

#### **CLOCK INPUT TIMING DIAGRAM**



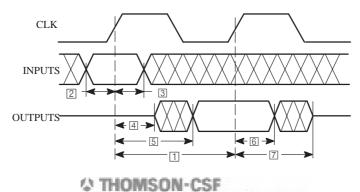
#### 4.4.2.AC Specifications

	Timing	TSPC2605-66			
Parameter	Reference	Min	Max	Unit	Notes
Clock Cycle Time	1	15	—	ns	
Input Setup Time	2	4.5	—	ns	1
Clock to Input Invalid (Input Hold)	3	2	—	ns	1
Clock to Output Driven	4	2	9	ns	2
Clock to Output Valid	5	2	9	ns	
Clock to Output Invalid	6	2	—	ns	2
Clock to Output High-Z	7	2	12	ns	2
PWRDN Disable to Recovery		—	4	μs	2

NOTES:

1. All input specifications are measured from the TTL level (0.8 or 2.0 V) of the signal in question to the 1.4 V level of the rising edge of the input clock. Both input and output timings are measured at the pin.

2. This parameter is sampled and not 100% tested.



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#### 4.4.3.TSPC2605 Response to 60X Transfer Attributes

TT0 – TT4	TBST	CI	WT	Tag Status	TSPC2605 Response	Notes
X1X10	0	1	Х	Miss	Line-fill (processor read miss)	1, 2, 3
X1X10	0	1	Х	Hit	L2 CLAIM, AACK, TA (processor read hit)	4
X1010	1	0	Х	Hit Clean	Paradox — Invalidate the line (processor n–cacheable read hit clean line)	
X1010	1	0	Х	Hit Dirty	Paradox — ARTRY, L2 BR, then write back data, invalidate the line (processor n–cacheable read hit dirty line)	
00110	0	1	Х	Miss	Line-fill except right after a snoop hit to processor (processor write miss)	1, 3, 5, 6
00110	0	1	1	Hit	L2 CLAIM, AACK, TA except after a snoop hit to processor (processor write hit)	5, 6
00X10	Х	1	0	Hit Clean	Cache update (processor write through WT hit clean)	
00110	0	1	0	Hit Dirty	Cache update, clear dirty bit	
00010	1	1	0	Hit Dirty	Paradox — ARTRY, L2 BR, write back data, keep valid, clear dirty bit	
X0010	1	0	Х	Hit Clean	Paradox — Invalidate the line (processor n–cacheable write hit clean line)	
X0010	1	0	Х	Hit Dirty	Paradox — $\overline{\text{ARTRY}}$ , $\overline{\text{L2 BR}}$ , then write back data, invalidate the line (processor n–cacheable SB write hit dirty line)	
00100	Х	Х	Х	Hit Clean	Invalidate tag (flush block address-only)	
00100	Х	Х	Х	Hit Dirty	ARTRY, L2 BR, write back data, invalidate tag (flush block address-only)	
00000	Х	Х	Х	Hit Clean	No action (clean block address–only)	
00000	Х	Х	Х	Hit Dirty	ARTRY, L2 BR, write back data, reset dirty bit (clean block address-only)	
01100	Х	Х	Х	Hit	Invalidate tag (kill block address-only)	

NOTES:

1. If a line fill is going to replace a dirty line and the cast out buffer (COB) is full, the line fill will be cancelled. (Unless the line fill is a write which hits in the COB. In this case, the line fill will occur.)

2. If a burst read misses the cache but hits the COB, the TSPC2605 will supply the data from the COB, but not perform a line fill.

3. If ARTRY is asserted during a line fill to replace a dirty line, the line fill will be cancelled, the to-be-replaced line will recover its old tag (valid, dirty, tag field), and the COB goes back to an invalid condition, even if the line fill is a burst write to the line in the COB.

4. If ARTRY is asserted during a read hit, the TSPC2605 will abort the process.

5. If a processor burst write occurs right after a snoop write that was a cache hit, the TSPC2605 will invalidate the line. If the snoop was a cache miss, the TSPC2605 will not perform a write allocate.

6. If a processor burst write occurs right after a snoop read that was a cache hit, the TSPC2605 will update the cache and clear the dirty bit. If the snoop was a cache miss, the TSPC2605 will perform a write allocate.

#### 4.4.4.TSPC2605 Response to Chipset Transfer Attributes

TT0 – TT4	Tag Status	TSPC2605 Response
00100 X0010 X1110	Hit Clean	Invalidate line
00100 X0010 X1110	Hit Dirty	ARTRY and L2 BR write back data, invalidate line (see Note)
00000 X1010	Hit Clean	No action
00000 X1010	Hit Dirty	ARTRY and L2 BR, write back data, reset dirty bit (see Note)
0110X 00110	Hit	Invalidate (kill block)

NOTE: In all snoop push cases, BR is sampled the cycle after the ARTRY window. If BR is asserted in this cycle, L2 BR will be immediately negated and an assertion of L2 BG will be ignored.

#### 4.4.5.Transfer Attributes Generated for L2 Copy–Back

TT0 – TT4	TBST	CI	WT
00010	0	1	1

# 4.5. JTAG AC Operating Conditions and Characteristics for the Test Access Port (IEEE 1149.1)

Input Timing Measurement Reference Level 1.	5 V
Input Pulse Levels 0 to 3.	0 V
Input Rise/Fall Time 3	ns

#### 4.5.1.TAP Controller Timing

		TSPC2	605–66		
Parameter	Symbol	Min	Мах	Unit	Notes
Cycle Time	t <sub>CK</sub>	30	_	ns	
Clock High Time	tскн	12	_	ns	1
Clock Low Time	t <sub>CKL</sub>	12	_	ns	1
Clock Low to Output Valid	t <sub>A</sub>	5	9	ns	
Clock Low to Output High-Z	t <sub>CKZ</sub>	0	9	ns	2
Clock Low to Output Active	t <sub>CKX</sub>	0	9	ns	3, 4
Setup Times: TMS TDI	t <sub>s</sub> t <sub>sd</sub>	2	—	ns	1
Hold Times: TMS TDI	t <sub>h</sub> t <sub>hd</sub>	2	—	ns	1

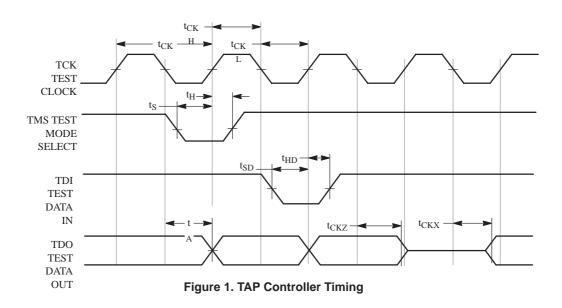
NOTES:

1. This parameter is sampled and not 100% tested.

2. TDO will High-Z from a clock low edge depending on the current state of the TAP state machine.

3. TDO is active only in the SHIFT-IR and SHIFT-DR state of the TAP state machine.

4. Transition is measured  $\pm$  500 mV from steady–state voltage. This parameter is sampled and not 100% tested.



# 5. FUNCTIONAL DESCRIPTION

#### 5.1. System Usage and Requirements

The TSPC2605 is a high-performance look-aside cache for PowerPC systems. A look-aside cache is defined as a cache that resides on the same bus as the processor, the memory controller, the DMA bridge, and the arbiter. The advantage of a look-aside cache is that, when the processor makes a memory request, the cache adds no delay to the memory controller's response time in the event that the request cannot be satisfied by the cache. However, there are certain system requirements that must be met before a look-aside cache can be used.

#### 5.1.1.Comprehension of L2 CLAIM

Because the memory controller sees every memory request that is issued by the processor, there must be a mechanism for the cache to inform the memory controller that it has detected a cache hit and that it will satisfy the processor's request. The TSPC2605 has a signal called L2 CLAIM that is asserted whenever a cache hit is detected. Any memory controller with which the TSPC2605 is to be used must have the ability to monitor this signal.

#### 5.1.2. Pipeline Depth

The 60X bus allows pipelining of transactions such that a new transaction can be initiated before a previous transaction has fully completed. The level of pipelining that exists on the bus is defined by how many new data transactions have been initiated while the original transaction is still being processed. By this definition the TSPC2605 can only work in a one level deep pipeline. In the presence of transactions for which it has asserted L2 CLAIM, the TSPC2605 can control the level of pipelining by delaying its assertion of AACK. However, for transactions that it cannot control, the TSPC2605 is dependent upon the memory controller to control pipeline depth. Thus, another system requirement for the use of the TSPC2605 is the use of a memory controller that only allows one level deep of pipelining on the 60X bus.

#### 5.1.3.Bus mastering

Bus mastering is a requirement only for systems which seek to use the TSPC2605 as a copyback, as opposed to a write-through, cache. The requirement is that the system arbiter must have the ability to allow the TSPC2605 to become a bus master. Specifically, the system arbiter must be able to recognize assertions of L2 BR and must have the ability to assert L2 BG and L2 DBG.

These are the only requirements above and beyond what should already exist in a PowerPC system. All other necessary control signals are signals that are required for the processor to communicate with the memory controller, the DMA bridge, and the arbiter.

#### 5.2. Configuration pins

The TSPC2605 has five configuration pins: CFG0, CFG1, CFG2, CFG3, and CFG4.

#### 5.2.1.CFG0 - CFG2

These three configuration pins are used to implement the different cache sizes supported by the TSPC2605.

- 256KB: For a single chip implementation, CFG0, CFG1, and CFG2 should all be tied low.
- 512KB: This two chip configuration requires both parts to have CFG0 tied low and CFG1 tied high. CFG2 is used as a chip select when it matches the value of A26. Therefore, one device must have CFG2 tied low and the other device must have CFG2 tied high.
- 1MB: The four chip configuration requires all four devices to have CFG0 tied high. The CFG1, CFG2 vector becomes the chip select when it matches the A25, A26 vector. Therefore, each of the four parts must have a unique value of the CFG[1:2] vector.

#### 5.2.2.CFG3

Many core logic chipsets are designed such that the DMA bridge and the memory controller are resident in the same device. In such systems there is internal communication between these two functional units. Bus transactions generated by the DMA bridge are solely for the purpose of keeping the system coherent. They are not explicit requests from memory that have data tenures associated with them. However, some chipsets are designed with the memory controller and the DMA bridge partitioned into different devices. In systems such as these, transactions generated by the DMA bridge are true memory requests that have data tenures associated with them. These are called snoop data tenures. Because these two types of systems are fundamentally different, the TSPC2605 must know in which type of system it is resident in order to respond properly to the different types of transactions. For systems that do not have snoop data tenures, CFG3 must be tied high. For systems that do use snoop data tenures, CFG3 must be tied low.

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#### 5.2.3.CFG4

When the TSPC2605 asserts L2 CLAIM to signal to the memory controller that a cache hit has been detected, it is taking control of the address and data tenures of the transaction (see **60X Bus Operation** and **Memory Coherence**). This means that the TSPC2605 will assert AACK to end the address tenure, and it will assert TA as needed for the data tenure. If the data bus is idle when a processor request is initiated, the TSPC2605 will assert AACK the cycle after TS was asserted. If the data bus is busy when the request is made, the TSPC2605 will wait until the outstanding data tenure has completed before asserting AACK. By holding off on the assertion of AACK, the TSPC2605 enforces the policy of, at most, two outstanding data transactions at any one time. Tying CFG4 low prevents the TSPC2605 from asserting AACK to end transactions for which it has asserted L2 CLAIM. In systems that tie CFG4 low it is necessary for the memory controller to assert AACK for all transactions. This allows the DMA bridge to initiate snoop transactions (as defined later) even when there are two outstanding data transactions. If this type of system is implemented, the arbiter must ensure that the processor's bus grant is negated once there are two outstanding data transactions. It is expected that most systems will tie CFG4 high.

# 5.3. Reset/Initialization

To ensure proper initialization and system functionality, the HRESET pin of the TSPC2605 should be connected to the same signal that is used to reset the processor. The TRST signal must be negated before HRESET is negated. When HRESET is negated, the TSPC2605 commences an internal initialization sequence to clear all of the valid bits in the cache. The sequence takes approximately 4000 clock cycles. During this time the TSPC2605 will not participate in any bus transaction that occurs. All transactions are, however, monitored so that, regardless of when the initialization sequence completes, the TSPC2605 is prepared to take action on the next transaction initiated by the processor.

At some point after this 4000 cycle sequence, the TSPC2605 will detect its first cache hit. At this time the system will experience its first assertion of L2 CLAIM. If the memory controller must be configured via software to comprehend assertions of L2 CLAIM, this configuration operation must have completed by this time. For systems that cannot guarantee that this requirement is met, it is necessary to disable the TSPC2605 until such time as this configuration can be guaranteed. Disabling the TSPC2605 can be accomplished by asserting L2 UPDATE INH sometime during reset and negating it when it is deemed safe for caching to commence.

#### 5.4. 60X bus operation

All transactions have what is called an address tenure. An address tenure is a set number of bus cycles during which the address bus and its associated control signals are being used for the transaction at hand. In general, there are two types of transactions. Those that only have address tenures, called address–only transactions. And those that require the use of the data bus and therefore will have a data tenure. These transactions are called data transactions. This section describes how address and data tenures are defined as viewed by the TSPC2605.

#### 5.4.1.Address Tenures

Address tenures on the 60X bus are fairly well defined. They start with an assertion of  $\overline{TS}$  by a device that has been granted the bus by the system arbiter. This device is called the bus master for this transaction. At the same time that  $\overline{TS}$  is asserted, the bus master also drives the address and all other relevant control signals that define the transaction.  $\overline{TS}$  is only asserted for one cycle but all other signals are held valid by the bus master until some other device asserts  $\overline{AACK}$ . The device that asserts  $\overline{AACK}$  becomes the slave to this transaction. Typically, the slave is the memory controller, although for transactions that are cache hits the TSPC2605 becomes the slave by driving  $\overline{L2 CLAIM}$ .

Transactions can be aborted by any device on the bus by asserting  $\overline{\text{ARTRY}}$ .  $\overline{\text{ARTRY}}$  may be asserted at any time after  $\overline{\text{TS}}$  is asserted, but must be held through the cycle after  $\overline{\text{AACK}}$  is asserted. This cycle is referred to as the ARTRY window, since it is the cycle in which all devices sample  $\overline{\text{ARTRY}}$  to determine if the address tenure has completed successfully.

If an address tenure is not aborted by an assertion of ARTRY, then the next bus master is free to assert TS, the cycle after the ARTRY window to start a new address tenure. If ARTRY is asserted in the ARTRY window, all devices that are not asserting ARTRY must negate their bus request in the following cycle. This next cycle is called the BR window. The purpose of this protocol is to give immediate bus mastership to the device that asserted ARTRY with the expectation that that device will take this opportunity to clean up whatever circumstances caused it to assert ARTRY. Typically, this involves writing data back to memory to maintain coherence in the system.

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#### 5.4.2.Data Tenures

Data tenures are more complicated to define than address tenures. They require two conditions to start: an assertion of  $\overline{TS}$  that initiates a data transaction and a qualified assertion of the bus master's data bus grant. For a data bus grant to be considered qualified, no device on the bus may be asserting  $\overline{DBB}$  in the cycle that the data bus grant is asserted.

Data transactions come in two types: single–beat transactions and burst transactions. The type is determined by the state of TBST during the address tenure of the transaction. If the bus master asserts TBST, the transaction is a burst transaction and will require four assertions of TA in order to complete normally. If TBST is negated during the address tenure, the transaction only requires one assertion of TA, thus the name single–beat.

Which device drives the data bus during a data transaction depends upon whether the transaction is a read or a write. For a read transaction, the slave device drives the data bus. For a write transaction, the master drives the data bus. In all data transactions, the slave device asserts TA to indicate that either valid data is present on the bus, in the case of a read; or that it is reading data off the data bus, in the case of a write. The master device asserts DBB the cycle after it has been granted the data bus and keeps it asserted until the data tenure has completed.

A data tenure can be aborted in two different ways. The address tenure for the transaction can be aborted by an assertion of ARTRY. Or, the slave device may assert TEA to indicate that some error condition has been detected. Either event will prematurely terminate the data tenure.

#### 5.4.3.Data Streaming

For the majority of data transactions there must be a wait state between the completion of one data tenure and the start of the next. This turnaround cycle avoids the contention on the data bus that would occur if one device starts driving data before another device has had a chance to turn off its data bus drivers. When a cache read hit is pipelined on top of another cache read hit, there is no need for this turnaround cycle since the same device will be driving the data bus for both data tenures. The 60X bus has the ability to remove this unnecessary wait state and allow back–to–back cache read hits to stream together. This ability is only enabled if the system is put into Fast L2 mode. Note that not all PowerPC processors support Fast L2 mode.

One of the requirements for taking advantage of this data streaming capability is that the system arbiter must be sophisticated enough to identify situations in which streaming may occur. Upon recognizing these situations, it must assert the processor's data bus grant in the cycle coincident with the fourth assertion of  $\overline{TA}$  of the first cache read, so that the data tenure for the second cache read may commence in the next cycle.

Because it only recognizes qualified assertions of  $\overline{CPU DBG}$ , the TSPC2605 must not be aware of the processor's assertions of  $\overline{DBB}$ . This means that the  $\overline{DBB}$  pin of the TSPC2605 must be tied to a pullup resistor rather than connected to the system  $\overline{DBB}$  to which all other devices are connected. This forces the system arbiter to a level of sophistication such that it only supplies qualified data bus grants and thus the  $\overline{DBB}$  signal is unnecessary to the whole system.

Note: In a multi–chip configuration each TSPC2605 device acts as an independent cache. Zero wait state data streaming can only occur if the back to back read hits occur in a given device. If the second read hit is not in the device as the first read hit, a wait state will occur between the two data tenures (2-1-1-2-1-1-1) timing).

#### 5.4.4.Data Bus Parking

The TSPC2605 has the ability to respond to a processor read or write hit starting in the cycle after the processor has asserted  $\overline{TS}$ . This is referred to as a 2–1–1–1 response. However, even though the TSPC2605 has this ability, it is dependent upon the system to allow this quick of a response to occur. As discussed above, a data tenure cannot start until the master has been given a qualified bus grant. In order for the data tenure to start the cycle after  $\overline{TS}$  is asserted, the data bus must be granted in the cycle coincident with the assertion of  $\overline{TS}$ . At bus speeds of 66 MHz it is extremely difficult for an arbiter to detect an assertion of  $\overline{TS}$  and itself assert  $\overline{CPUDBG}$  in the same cycle. In order to realistically allow this situation to occur,  $\overline{CPUDBG}$  must be asserted independent of the processor's assertion of  $\overline{TS}$ .

Data bus parking is a system feature whereby the processor always has a qualified data bus grant when the data bus is idle. It is also a requirement for systems which seek to take advantage of the 2–1–1–1 response time capabilities of the TSPC2605. This feature is typically present in arbiters that have the level of sophistication necessary to support data streaming. But it is also a feature of systems that do not even have a data bus arbiter. In these systems the data bus grant of every device in the system is tied to ground. The assertion of DBB by the current data bus master effectively removes the qualified data bus grant of all devices in the system, including its own. Note that in systems that have no data bus arbiter that it is impossible to take advantage of data streaming.

There is another caveat associated with data bus parking. Care must be taken when using data bus parking along with Fast L2 mode. In normal bus mode when the processor reads data off the bus, it will wait one cycle before passing the data on to internal functional units. The purpose of this one cycle waiting period is to check for an assertion of DRTRY, which invalidates the data that has been already read. One of the advantages of running the processor in Fast L2 mode is that this internal processor wait state is removed.

A problem will arise, however, if the processor is given data the cycle after  $\overline{TS}$  is asserted, as is possible with the TSPC2605, and the transaction is aborted by some other device asserting  $\overline{ARTRY}$ . Because the processor will not sample  $\overline{ARTRY}$  until two cycles after the assertion of  $\overline{TS}$ , the data read off the bus will have already been forwarded to the internal functional units. Thus, incorrect results may occur in the system.

To avoid this situation in a system that seeks to run Fast L2 mode with the data bus parked, there must be a guarantee that ARTRY will never be asserted for cache read hits. This is a further requirement to be imposed upon the DMA bridge and the memory controller. If this guarantee cannot be made, the data bus cannot be parked when running in Fast L2 mode.

#### 5.4.5.Processor Reads

When the processor issues a read transaction, the TSPC2605 does a tag lookup to determine if this data is in the cache. If there is a cache hit and Cl is not asserted, the TSPC2605 will assert L2 CLAIM and supply the data to the processor when the data tenure starts.

If the processor issues a cache–inhibited read (CI asserted) and the TSPC2605 detects a cache hit to a non–dirty, or clean, cache line, the line will be marked invalid. If the cache–inhibited read hits a dirty line, the TSPC2605 will assert ARTRY and write the dirty line back to memory.

If the read misses in the cache, the TSPC2605 will perform a linefill only if it is a burst read and it is not marked cache-inhibited. During a linefill, the TSPC2605 stores the data present on the bus as it is supplied by the memory controller.

#### 5.4.6.Processor Writes

The conditions for asserting L2 CLAIM for processor writes are almost the same as for processor reads. There must be a cache hit and CI must not be asserted. In addition, however, WT must not be asserted. Single beat writes that are marked either write–through or cache–inhibited that hit in the cache cause the TSPC2605 to assert ARTRY and write the dirty line back to memory.

#### 5.4.7.Transaction Pipelining

As explained in **Pipeline Depth**, the TSPC2605 can only handle one level of pipelining on the bus. Since the assertion of  $\overline{L2 \text{ CLAIM}}$  gives it the ability to assert  $\overline{AACK}$ , the TSPC2605 has the ability to control this pipeline depth for transactions that are cache hits by delaying its assertion of  $\overline{AACK}$ .

Pipelined cache hits are transactions that hit in the cache but occur while there is still an outstanding data transaction on the bus. The timing of the assertion of  $\overline{AACK}$  for a pipelined cache hit is dependent upon the completion of the previous transaction. For explanation purposes, the previous transaction will be referred to as transaction one. The pipelined cache hit will be referred to as transaction two.

If transaction one is a cache hit, the TSPC2605 will be the slave device for the transaction. Since, for burst operations, the TSPC2605 always asserts  $\overline{TA}$  for four consecutive clock cycles, the end of the data tenure for transaction one will be at a deterministic clock cycle. In this case,  $\overline{AACK}$  for transaction two can be asserted coincident with the last assertion of  $\overline{TA}$  for transaction one. If transaction one is not a cache hit, the TSPC2605 will wait until after the data tenure for transaction one has completed before asserting  $\overline{AACK}$  to complete the address tenure of transaction two.

#### 5.5. Memory coherence

When a processor brings data into its on-chip cache and modifies it, a situation has arisen in which the main memory now contains irrelevant, or stale, data. Given that most systems support some form of DMA there must exist a means by which the processor is forced to write this modified, or dirty, data back to main memory. The DMA bridge is responsible for generating bus transactions to ensure that main memory locations accessed by DMA operations do not contain stale data. These transactions, called snoops, come in three different categories, each of which will be discussed below.

Snoops cause the processor and the TSPC2605 to check to see if they have dirty copies of the memory location specified in the snoop transaction. If either device does have a dirty copy it will assert ARTRY and make use of the opportunity presented in the BR window to write this data back to main memory.

Situations can arise where a cache line is dirty in both the processor's L1 cache and in the TSPC2605. In cases such as these, snoop transactions should cause the processor to write its data back to memory since it is by definition more recent than the data in the TSPC2605. Since ARTRY is a shared signal and it cannot be determined which devices are driving it, the TSPC2605 samples CPU BR in the BR window to determine if the snoop hit a dirty line in the L1 cache. If CPU BR is asserted during this window, the TSPC2605 will defer to the processor.

#### 5.5.1.Snoop Reads

A snoop read causes dirty data to be written back to memory but allows both the L1 and L2 to keep a valid copy. In cases where the snoop hits a dirty cache line in the processor, the TSPC2605 will update its contents as the processor writes the data back to main memory.

Snoop reads can be implemented in two ways. One is that the DMA bridge can issue a clean transaction (TT[0:4] = 00000). The other is that the DMA bridge can do a read transaction (TT[0:4] = x1010). If the DMA bridge does a read transaction, the TSPC2605 determines that it is a snoop read rather than a processor read by the state of CPU BG the cycle before TS was asserted. If the processor was not granted the bus then the transaction had to have been issued by the DMA bridge and is therefore a snoop read.

#### 5.5.2.Snoop Writes

Snoop writes also cause dirty data to be written back to main memory. The difference from a snoop read is that the cache line must then be invalidated in both the processor's cache and in the L2 cache. When the processor writes data back to memory in response to a snoop write, the TSPC2605 will not cache the data as it appears on the bus. If a valid copy resides in the cache, the TSPC2605 will invalidate it.

Again there are multiple transactions that can be used by the DMA bridge to implement a snoop write. It can issue a flush transaction (TT[0:4] = 00100), a read with intent to modify (TT[0:4] = x1110), or a write with flush (TT[0:4] = 00010). As with snoop reads, the TSPC2605 distinguishes between processor issued data transactions and snoop transactions by the state of CPU BG in the cycle previous to the assertion of TS.

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#### 5.5.3.Snoop Kills

Kills are snoops that cause cache entries to be immediately invalidated, regardless of whether they are dirty. This saves time if the DMA operation is going to modify all the data in the cache line. To implement a snoop kill the DMA bridge can issue a kill transaction (TT[0:4] = 01100) or a write with kill (TT[0:4] = 00110).

## 5.6. Two/Four Chip Implementation

#### 5.6.1.Multiple Castouts

Because each TSPC2605 has its own castout buffer (COB), it is possible for situations to arise in which more than one device needs to do a copyback operation. Under normal circumstances each device will enter castout conditions at different times. In these cases, when a device determines that it needs to do a castout, the L2 BR signal is first sampled. If L2 BR is already asserted then it is clear that another device is also in a castout situation. The late device will wait until L2 BR is negated before continuing in its attempt to perform its castout.

Because of the BR window protocol associated with assertions of  $\overline{ARTRY}$ , it is possible for a situation to arise where device two is waiting for device one to do its castout before asserting  $\overline{L2BR}$ . If there is an assertion of  $\overline{ARTRY}$  by a device other than device one, device one is required to negate  $\overline{L2BR}$  in the BR window. In order to prevent device two from interpreting device one's negation of  $\overline{L2}$  BR as an indication that device one has completed its castout, a simple arbitration mechanism is used. All devices have a simple two–bit counter that is synchronized such that all counters always have the same value. For the purposes of performing a castout operation, a given pair can only assert  $\overline{L2BR}$  if the counter is equal to its value of CFG[1:2]. This simple mechanism prevents more than one device from asserting  $\overline{L2BR}$  in the same cycle and therefore not being cognizant of the another device's need to perform a castout.

#### 5.6.2. Snoop Hit Before Castout

The other situation that can cause problems with a shared bus request occurs when a snoop hits a dirty line in one of the TSPC2605 devices. If device one has a cache line in its COB, it will assert L2 BR so that it may perform a castout operation. If a snoop hits a dirty line in device two, it will assert both  $\overline{\text{ARTRY}}$  and  $\overline{\text{L2 BR}}$  so that it can write the snoop data back to main memory. When device one detects that  $\overline{\text{ARTRY}}$  has been asserted, it needs to be made aware that device two needs to request the bus. Otherwise, at the same time that device two is asserting  $\overline{\text{L2 BR}}$ , device one will attempt to conform to the BR window protocol and negate  $\overline{\text{L2 BR}}$ . This situation is avoided by device one sampling FDN when it detects that  $\overline{\text{ARTRY}}$  has been asserted at the same time as  $\overline{\text{ARTRY}}$  is asserted, device one will recognize that device two is asserting  $\overline{\text{ARTRY}}$ . device one will then high–Z  $\overline{\text{L2 BR}}$  so that there will not be contention when device two is asserting  $\overline{\text{L2 BR}}$ .

#### 5.7. Multiprocessing

The TSPC2605 can be used as a common cache for up to four processors. For each processor there is a bus request, bus grant, and data bus grant signal pin on the TSPC2605. Each of these pins needs to be connected to the respective processor's arbitration signals in the system.

The TSPC2605 treats multiple processors as one processor. Thus, the same restrictions on pipelining depth are true with regard to how many processor transactions can be outstanding at any one time. There can only be one data transaction from ANY processor pipelined on top of a current data transaction that was issued by ANY processor.

The data tenures for all processors must be performed in the same order as the address tenures on a system–wide basis. If processor one makes a request and then processor two makes a request, processor one's data tenure must precede processor two's data tenure. Note that this is not a 60X bus restriction, but rather a restriction necessary for proper operation of the TSPC2605.

The TSPC2605 keeps coherent with the L1 caches of multiple processors as defined by the MESI (modified–exclusive–shared–invalid) protocol without actually implementing the protocol. This is possible for two reasons. Since the TSPC2605 is a look–aside cache, all transactions are monitored by all devices on the bus. Also, the TSPC2605 cannot, on its own, modify data. Thus, if one processor requests exclusive access to a cache line, it is not necessary for the TSPC2605 to invalidate its copy of the data, as would be required under the MESI protocol. If a second processor requests the same data, the transaction will cause the first processor to assert <u>ARTRY</u>. This will prevent the TSPC2605 from supplying stale data to the second processor.

As discussed in **Data Bus Parking**, care must be taken when parking the data bus in Fast L2 mode. By the nature of MP systems running under the MESI protocol there will be assertions of ARTRY to abort cache read hits. Thus, in an MP system, the data bus cannot be parked to any processor if the system is to be run in Fast L2 mode.

#### 5.8. Powering-Down

An assertion of PWRDN will cause the TSPC2605 to go into a low–power sleep state. This state is entered after PWRDN is synchronized and both the address and data buses are idle. All data is retained while in the sleep state.

The behavior of the TSPC2605 upon negation of PWRDN is dependent upon the state of WT at the rising edge of HRESET. If WT is asserted at reset, the TSPC2605 will invalidate all cache entries when  $\overline{PWRDN}$  is negated. If  $\overline{WT}$  is negated at reset, the TSPC2605 will invalidate all cache entries when  $\overline{PWRDN}$  is negated. If  $\overline{WT}$  is negated at reset, the TSPC2605 will leave all cache entries as they were prior to the assertion of  $\overline{PWRDN}$ . However, in this situation, the system designer must insure that no bus activity occur within two microseconds of the negation of  $\overline{PWRDN}$ .

Note: While in the sleep state the TSPC2605 does not disable its internal clock network. The low power state current stated in this specification assumes that the system clock is not toggling.

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# 5.9. Asynchronous signals

The TSPC2605 supports four asynchronous control signals. These signals were originally defined in the PowerPC reference platform (PReP) specification. Because these signals are defined to be asynchronous, the TSPC2605 must synchronize them internally. This process takes eight clock cycles. Thus, to guarantee recognition by the TSPC2605, assertions of any one of these signals must last a minimum of eight clock cycles.

#### 5.9.1.L2 FLUSH

When L2 FLUSH is asserted, the TSPC2605 initiates an internal sequence that steps through every cache line present. Valid lines that are clean are immediately marked invalid. Valid lines that are dirty must be written back to main memory.

To keep memory up to date, the TSPC2605 must still monitor all transactions on the bus. Any transaction that is not a processor burst write will cause the TSPC2605 to assert ARTRY. Burst writes cause the TSPC2605 to do a lookup on the affected address and mark the line invalid if it is present.

Because the TSPC2605 must still monitor all transactions, it cannot use the tag RAM for the flush sequence unless there is a guarantee that no new transaction will be initiated on the bus. The only way to ensure that no new transactions will occur is for the TSPC2605 to be granted the bus. Thus, upon entering the sequence initiated by the assertion of L2 FLUSH, the TSPC2605 will assert L2 BR. As soon as L2 BG is asserted, the TSPC2605 can start stepping through the tag RAM entries.

L2 FLUSH need not be held asserted for the flush sequence to complete. Once started the sequence will run to completion unless overridden by an assertion of HRESET.

#### 5.9.2.L2 MISS INH

When L2 MISS INH is asserted, the TSPC2605 will not load any new data into the cache. The data already present will remain valid and the TSPC2605 will respond to cache hits. This condition only lasts as long as L2 MISS INH is asserted. When L2 MISS INH is negated, the TSPC2605 will start to bring new data into the cache when there are cache misses.

#### 5.9.3.L2 TAG CLR

When L2 TAG CLR is asserted, the TSPC2605 will invalidate all entries in the cache. This internal sequence is the same as the one initiated by an assertion of HRESET. During this sequence, the TSPC2605 will not participate in any bus transaction. However, it will keep track of all bus transactions so that when the sequence is finished, the TSPC2605 can immediately participate in the next bus transaction.

As is the case with assertions of L2 FLUSH, an assertion of L2 TAG CLR need not be held for the duration of the sequence. Once asserted the sequence will run to completion regardless of the state of L2 TAG CLR.

#### 5.9.4.L2 UPDATE INH

When L2 UPDATE INH is asserted, the TSPC2605 is disabled from responding to cacheable transactions. Bus transactions continue to be monitored so that as soon as L2 UPDATE INH is negated, the MPC204GA can participate in the next transaction.

# 5.10. Waveforms

#### 5.10.1.Read HIT/Write HIT

Figure 1 shows a read hit from an idle bus state. The TSPC2605 asserts  $\overline{L2 \text{ CLAIM}}$  the cycle after  $\overline{TS}$  to inform the memory controller that there is a cache hit and the cache will control the rest of the transaction.  $\overline{L2 \text{ CLAIM}}$  is held through the cycle after  $\overline{AACK}$  is asserted. Since there are no active data tenures from previous transactions, the TSPC2605 asserts  $\overline{AACK}$  the cycle after  $\overline{TS}$  is asserted. Note there must be a qualified assertion of  $\overline{CPU DBG}$  in the same cycle as the assertion of  $\overline{TS}$  for the TSPC2605 to respond with  $\overline{TA}$  in the next cycle.  $\overline{CPU DBG}$  does not affect the timing of  $\overline{L2 \text{ CLAIM}}$  or  $\overline{AACK}$ .

The write hit timing is virtually the same. The only difference is the processor drives the data instead of the TSPC2605.

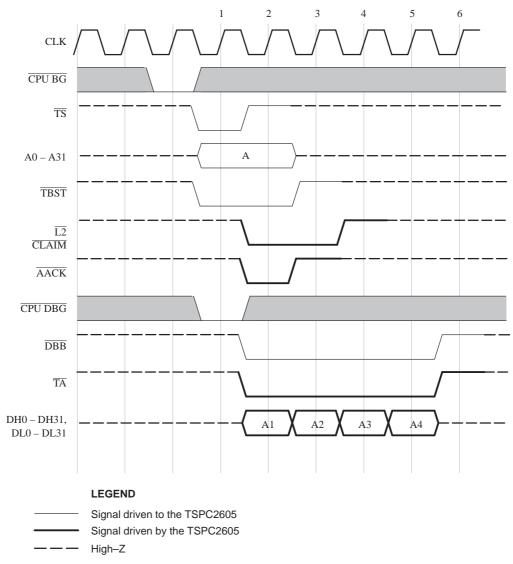


Figure 1. Burst Read (or Write) Hit

# 5.10.2. Multiple Read/Write HITS (NORMAL BUS MODE)

Figure 2 is an illustration of TSPC2605 pipeline depth limit with multiple read hits. The TSPC2605 supports only one level of address pipelining for data transfer. Therefore, it must hold off on its assertion of AACK for a pipelined TS until the data tenure for the first TS is done. The TSPC2605 asserts AACK at the same time as the fourth TA for data tenures that it controls.

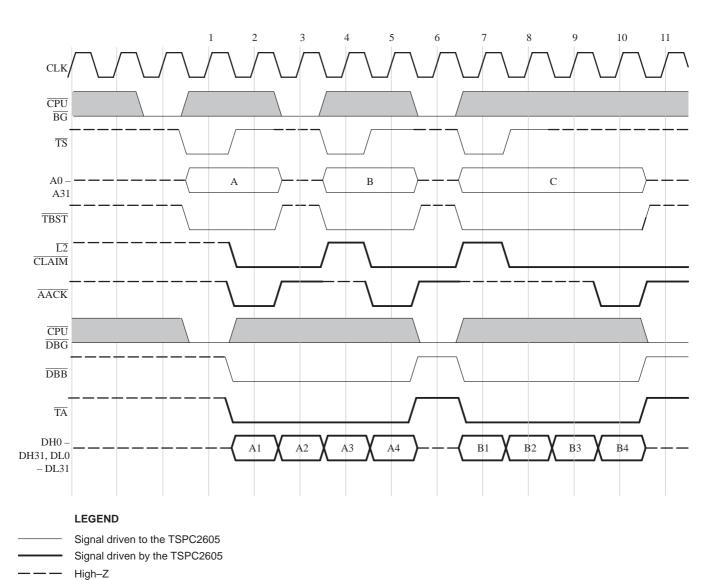
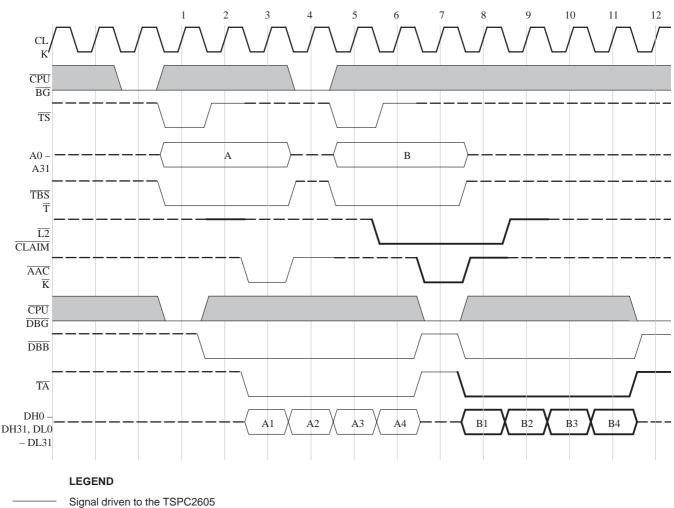


Figure 2. Multiple Burst Read (or Write) Hits

#### 5.10.3.Read MISS (NORMAL BUS MODE)

Figure 3 is an illustration of TSPC2605 pipeline depth with a read miss followed by a read hit.

For illustration purposes the read miss is shown as a 3-1-1-1 response from memory. AACK for the second access is not driven true until the cycle after the fourth TA of the read miss. This is because the TSPC2605 is not in control of TA for the first access and must, therefore, wait until the first access' data tenure is complete before it can drive AACK true for the read hit.



Signal driven by the TSPC2605

——— High–Z

Figure 3. Read Miss Followed by a Burst Read Hit for MPC603/604

# 5.10.4. Multiple read HITS (FAST L2 MODE)

Back to back pipelined burst read hits for the MPC604 in Fast L2 mode, also called data streaming mode, are shown in Figure 4. Note that CPU DBG is negated except for the cycles coincident with the fourth TA of each data tenure. This is a requirement for data streaming. Note also that DBB is not shown. For proper operation in Fast L2 mode the DBB pin of the TSPC2605 must be tied to a pull–up resistor.

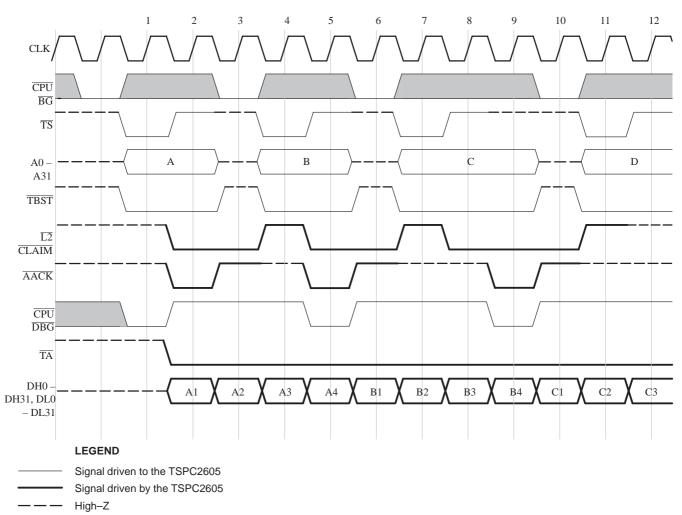


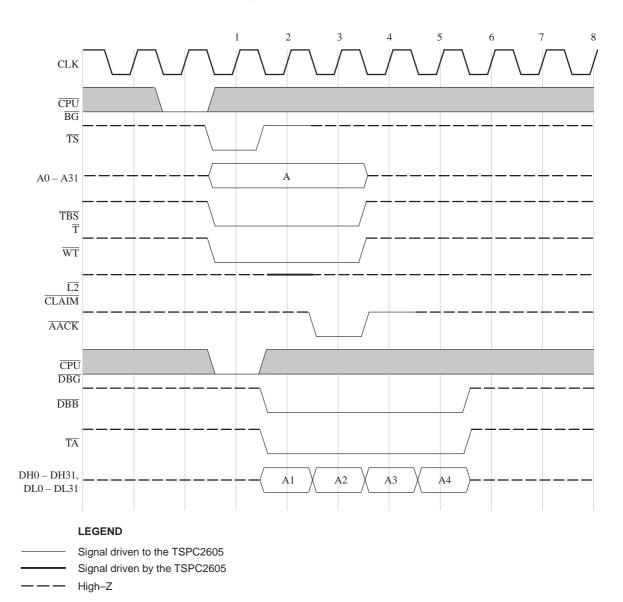
Figure 4. Multiple Burst Read Hits in Fast L2 Mode

#### 5.10.5.Write Through Burst Write HIT

Figure 5 shows the fastest possible burst write hit to a write-through mode L2 cache line, read miss or write miss processing that replaces a clean line. For these operations TSPC2605 will not assert any signals on the 60X bus. A cache line is considered write through if  $\overline{WT}$  is asserted by the processor when it asserts  $\overline{TS}$ .

The speed at which a write-through operation completes is solely dependent on the memory controller. The timing shown

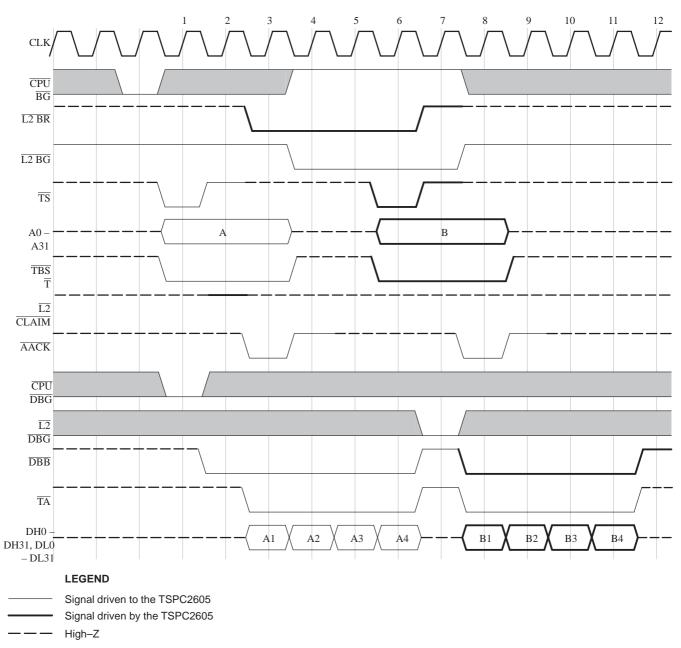
here assumes that the memory controller has a write buffer that can accept data this quickly.





## 5.10.6.Read/Write MISS

Figure 6 is an illustration of a processor read or write miss that causes the TSPC2605 to replace a dirty line. L2 BR is asserted two clocks after TS. The dirty data to be replaced is moved into the internal cast out buffer (COB) at the same time the new data is written into the cache. Note that the copyback operation occurs after the processor request is satisfied. In addition, no delay is added to the processor transaction. It proceeds as fast as the memory controller will allow.





#### 5.10.7.Read/Write Snoop HIT (DIRTY L2 LINE)

Figure 7 is an illustration of a read or write snoop to a cache line that is dirty in the L2, but is not dirty in the processor's cache. When a snoop hits a dirty line, the TSPC2605 will assert  $\overline{ARTRY}$  through the cycle following the assertion of  $\overline{AACK}$ . This cycle is called the ARTRY window. Note that the TSPC2605 also asserts  $\overline{L2BR}$  at the same time it asserts  $\overline{ARTRY}$ . Because the snoop could also have hit a dirty line in the processor's cache, the TSPC2605 samples the processor's  $\overline{BR}$  signal the cycle following the ARTRY window. This cycle is called the BR window. If the processor's  $\overline{BR}$  signal is not asserted, the TSPC2605 will start sampling  $\overline{L2BG}$ , the cycle after the BR window.

Note that the TSPC2605 cannot do a 2-1-1-1 copy back burst. The earliest that it can handle the first assertion of TA is two cycles after its assertion of TS.

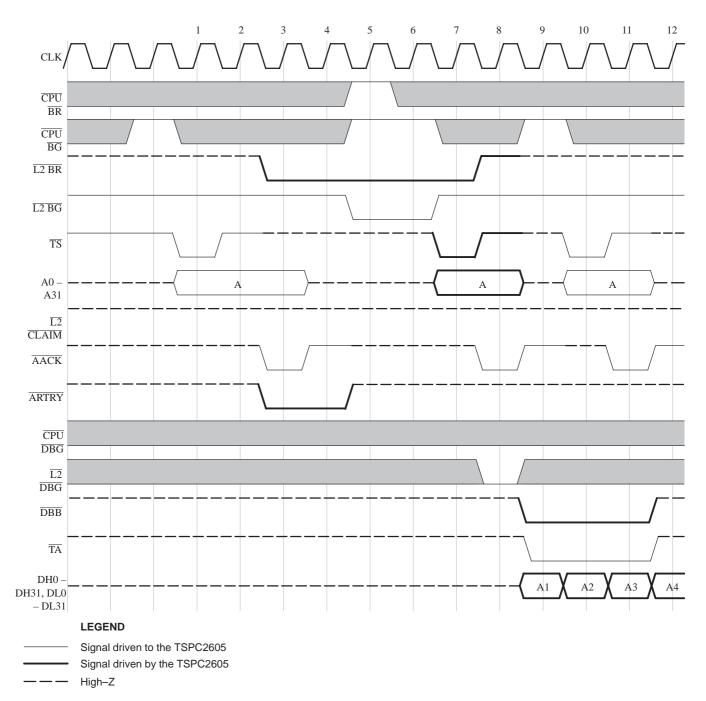
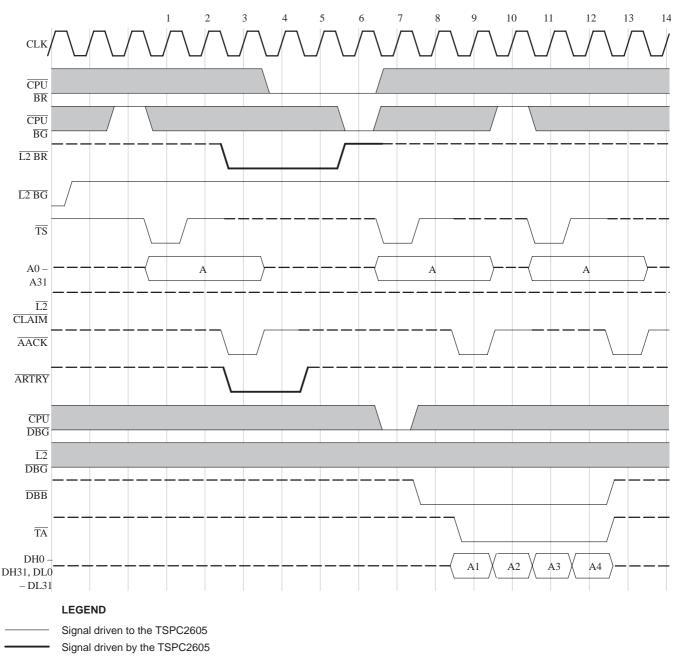


Figure 7. Read or Write Snoop Hit to Dirty L2 Cache Line and Clean Processor Cache Line

# 5.10.8.Read/Write Snoop HIT (DIRTY L2 AND PROCESSOR LINE)

An illustration of PowerPC read or write snoop hit to a dirty L2 cache line is shown in Figure 8. The processor has a dirty copy of the cache line. In this case, both the processor and the TSPC2605 assert  $\overline{ARTRY}$ . This situation is detected by sampling  $\overline{CPUBR}$  in the BR window, as described in the previous example. If  $\overline{CPUBR}$  is asserted in the BR window, the TSPC2605 will negate  $\overline{L2BR}$ . It will also ignore assertions of  $\overline{L2BG}$ . This allows the processor to write back its dirty cache line, at which time the TSPC2605 will either update or invalidate its copy depending on whether it is a snoop read or snoop write.



— — — High–Z

Figure 8. Read or Write Snoop Hit to Dirty L2 Cache Line and Dirty Processor Cache Line

#### 5.10.9.Read HIT/Write HIT (WITHOUT CPU DBG PARKED)

Most of the previous examples have assumed  $\overline{CPUDBG}$  is asserted in the same cycle that the processor asserts  $\overline{TS}$ . This implies  $\overline{CPUDBG}$  is parked. In some systems it may not be desirable or possible to park  $\overline{CPUDBG}$ . Figure 9 shows the response for a read hit from the TSPC2605 is gated by the assertion of  $\overline{CPUDBG}$ . The fastest response possible in a system that does not park  $\overline{CPUDBG}$  is 3-1-1-1.

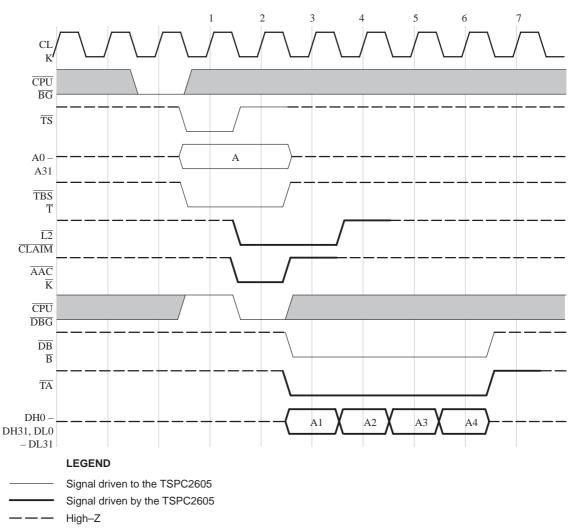


Figure 9. Burst Read (or Write) Hit Without CPU DBG Parked

# 5.11. Test Access Port Description

#### 5.11.1.Instruction Set

A five pin IEEE Standard 1149.1 Test Port (JTAG) is included on this device. When the TAP (Test Access Port) controller is in the SHIFT–IR state, the instruction register is placed between TDI and TDO. In this state, the desired instruction would be serially loaded through the TDI input. TRST resets the TAP controller to the test–logic reset state. The TAP instruction set for this device are as follows.

#### 5.11.2. Standard Instructions

Instruction	Code (Binary)	Description
BYPASS	1111*	Bypass instruction
SAMPLE/PRELOAD	0010	Sample and/or preload instruction
EXTEST	0000	Extest instruction
HIGHZ	1001	High–Z all output pins while bypass register is between TDI and TDO
CLAMP	1100	Clamp output pins while bypass register is between TDI and TDO

\* Default state at power-up.

#### 5.11.3.SAMPLE/PRELOAD TAP Instruction

The SAMPLE/PRELOAD TAP instruction is used to allow scanning of the boundary–scan register without causing interference to the normal operation of the chip logic. The 169–bit boundary–scan register contains bits for all device signal and clock pins and associated control signals. This register is accessible when the SAMPLE/PRELOAD TAP instruction is loaded into the TAP instruction register in the SHIFT–IR state. When the TAP controller is then moved to the SHIFT–DR state, the boundary–scan register is placed between TDI and TDO. This scan register can then be used prior to the EXTEST instruction to preload the output pins with desired values so that these pins will drive the desired state when the EXTEST instruction is loaded. As data is written into TDI, data also streams out TDO which can be used to pre–sample the inputs and outputs.

SAMPLE/PRELOAD would also be used prior to the CLAMP instruction to preload the values on the output pins that will be driven out when the CLAMP instruction is loaded.

#### 5.11.4.EXTEST TAP Instruction

The EXTEST instruction is intended to be used in conjunction with the SAMPLE/PRELOAD instruction to assist in testing board level connectivity. Normally, the SAMPLE/PRELOAD instruction would be used to preload all output pins. The EXTEST instruction would then be loaded. During EXTEST, the boundary–scan register is placed between TDI and TDO in the SHIFT–DR state of the TAP controller. Once the EXTEST instruction is loaded, the TAP controller would then be moved to the run–test/idle state. In this state, one cycle of TCK would cause the preloaded data on the output pins to be driven while the values on the input pins would be sampled. Note the TCK, not the clock pin (CLK), is used as the clock input while CLK is only sampled during EXTEST. After one clock cycle of TCK, the TAP controller would then be moved to the shifted out of TDO (and new values would be shifted in TDI). These values would normally be compared to expected values to test for board connectivity.

#### 5.11.5.CLAMP TAP Instruction

The CLAMP instruction is provided to allow the state of the signals driven from the output pins to be determined from the boundaryscan register while the bypass register is selected as the serial path between TDI and TDO. The signals driven from the output pins will not change while the CLAMP instruction is selected. EXTEST could also be used for this purpose, but CLAMP shortens the board scan path by inserting only the bypass register between TDI and TDO. To use CLAMP, the SAMPLE/PRELOAD instruction would be used first to scan in the values that will be driven on the output pins when the CLAMP instruction is active.

#### 5.11.6.HIGHZ TAP Instruction

The HIGH–Z instruction is provided to allow all the outputs to be placed in an inactive drive state (high–Z). During the HIGH–Z instruction the bypass register is connected between TDI and TDO.

#### 5.11.7.BYPASS TAP Instruction

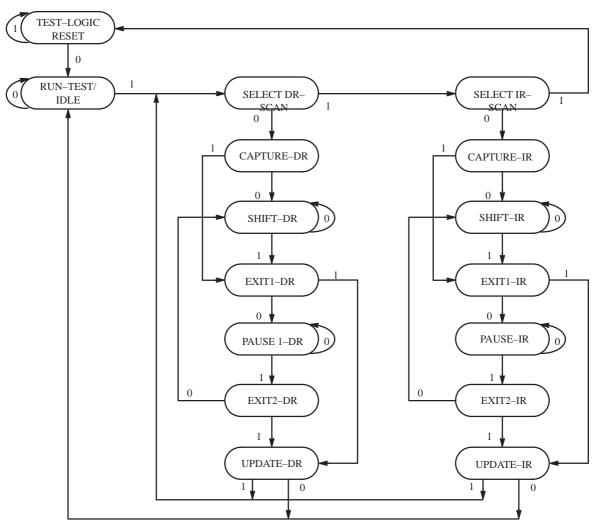
The BYPASS instruction is the default instruction loaded at power up. This instruction will place a single shift register between TDI and TDO during the SHIFT–DR state of the TAP controller. This allows the board level scan path to be shortened to facilitate testing of other devices in the scan path.

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#### 5.11.8.Disabling the Test Access Port and Boundary Scan

It is possible to use this device without utilizing the four pins used for the test access port. To circuit disable the device, TCK must be tied to  $V_{SS}$  to preclude mid level inputs. TRST should be tied to  $V_{SS}$  to ensure proper HRESET operation. Although TDI and TMS are designed in such a way that an undriven input will produce a response equivalent to the application of a logic 1, it is still advisable to tie these inputs to  $V_{DD}$  through a 1K resistor. TDO should remain unconnected.



NOTE: The value adjacent to each state transition represents the signal present at TMS at the rising edge of TCK.

Figure 10. TAP Controller State Diagram

# 5.12. Boundary Scan Order

#### 5.12.1.Bit number

The order of the boundary scan chain. Bit 0 is the closest to TDO.

#### 5.12.2.Bit/pin name

The name of the physical pin. For an output enable cell, this is the name of the corresponding output enable.

#### 5.12.3.Bit/pin type

**Input** — Input only pin.

**I/O** — Bi–directional pin that can be put into high–Z state.

Output — Output only pin.

**Output Enable** — Boundary scan cell to hold the output enable state of other I/O pads. Output enable does not correspond to a physical pin. To set an I/O to an input, the output enable must have a 1. To set an I/O to an output, the output enable must have a 0. Note that these internal output enables are active low.

**Reserved** – This signal is reserved and must always be a 1.

#### 5.12.4.Output enable

The name of the output enable cell that determines if the cell is enabled or in the high–Z state. If the pin type is input or output enable, this entry will be empty.

Bit Number	Bit/Pin Name	Bit/Pin Type	Output Enable
0	Reserved	Reserved	
1	DL16	I/O	DOE
2	DL17	I/O	DOE
3	DL18	I/O	DOE
4	DL19	I/O	DOE
5	DL20	I/O	DOE
6	DL21	I/O	DOE
7	DL22	I/O	DOE
8	DL23	I/O	DOE
9	DP6	I/O	DOE
10	DL24	I/O	DOE
11	DL25	I/O	DOE
12	DL26	I/O	DOE
13	DL27	I/O	DOE
14	DL28	I/O	DOE
15	DL29	I/O	DOE
16	DL30	I/O	DOE
17	DL31	I/O	DOE
18	DP7	I/O	DOE
19	DH24	I/O	DOE
20	DH25	I/O	DOE
21	DH26	I/O	DOE
22	DH27	I/O	DOE
23	DH28	I/O	DOE
24	DH29	I/O	DOE
25	DH30	I/O	DOE
26	DH31	I/O	DOE

Bit Number	Bit/Pin Name	Bit/Pin Type	Output Enable
27	DP3	I/O	DOE
28	DH16	I/O	DOE
29	DH17	I/O	DOE
30	DH18	I/O	DOE
31	DH19	I/O	DOE
32	DH20	I/O	DOE
33	DH21	I/O	DOE
34	DH22	I/O	DOE
35	DH23	I/O	DOE
36	DP2	I/O	DOE
37	L2 BG	Input	
38	L2 MISS INH	Input	
39	ABB	I/O	ABBOE
40	CPU3 DBG	Input	
41	CPU3 BG	Input	
42	CPU3 BR	Input	
43	CPU2 DBG	Input	
44	CPU2 BG	Input	
45	CPU2 BR	Input	
46	FDN	I/O	FDNOE
47	L2 DBG	Input	
48	L2 BR	I/O	L2BROE
49	TA	I/O	TAOE
50	L2 CLAIM	Output	L2CLAIMOE
51	CPU DBG	Input	
52	AACK	I/O	AACKOE
53	CI	I/O	AOE

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Bit Number	Bit/Pin Name	Bit/Pin Type	Output Enable
54	ARTRY	I/O	ARTRYOE
55	WT	I/O	AOE
56	CPU BR	Input	
57	TEA	Input	
58	PWRDN	Input	
59	DBB	I/O	DBBOE
60	HRESET	Input	
61	TBST	I/O	AOE
62	тто	I/O	AOE
63	TS	I/O	AOE
64	TT1	I/O	AOE
65	TT2	I/O	AOE
66	TT4	I/O	AOE
67	TT3	I/O	AOE
68	CPU BG	Input	
69	SRESET	Input	
70	L2 TAG CLR	Input	
71	L2 UPDATE INH	Input	
72	CPU4 BG	Input	
73	CPU4 DBG	Input	
74	CPU4 BR	Input	
75	CFG0	Input	
76	CFG2	Input	
77	CFG1	Input	
79	DH8	I/O	DOE
79	DH9	I/O	DOE
80	DH10	I/O	DOE
81	DH11	I/O	DOE
82	DH12	I/O	DOE
83	DH13	I/O	DOE
84	DH14	I/O	DOE
85	DH15	I/O	DOE
86	DP1	I/O	DOE
87	DH0	I/O	DOE
88	DH1	I/O	DOE
89	DH2	I/O	DOE
90	Dh3	I/O	DOE
91	DH4	I/O	DOE
92	DH5	I/O	DOE
93	DH6	I/O	DOE
94	DH7	I/O	DOE
95	DP0	I/O	DOE
96	DL0	I/O	DOE

Bit Number	Bit/Pin Name	Bit/Pin Type	Output Enable
97	DL1	I/O	DOE
98	DL2	I/O	DOE
99	DL3	I/O	DOE
100	DL4	I/O	DOE
101	DL5	I/O	DOE
102	DL6	I/O	DOE
103	DL7	I/O	DOE
104	DP4	I/O	DOE
105	DL8	I/O	DOE
106	DL9	I/O	DOE
107	DL10	I/O	DOE
108	DL11	I/O	DOE
109	DL12	I/O	DOE
110	DL13	I/O	DOE
111	DL14	I/O	DOE
112	DL15	I/O	DOE
113	DP5	I/O	DOE
114	A0	I/O	AOE
115	A1	I/O	AOE
116	A2	I/O	AOE
117	A3	I/O	AOE
118	A4	I/O	AOE
119	A5	I/O	AOE
120	A6	I/O	AOE
121	A7	I/O	AOE
122	A8	I/O	AOE
123	A9	I/O	AOE
124	A10	I/O	AOE
125	A11	I/O	AOE
126	A12	I/O	AOE
127	A31	1/0	AOE
128	A30	I/O	AOE
129	A29	1/O	AOE
130	A28	1/O	AOE
131	A27	1/O	AOE
132	A26	1/0	AOE
133	A25	1/0	AOE
134	A24	1/0	AOE
135	A24 A23	1/0	AOE
135	A23 A22	1/0	AOE
130	A22 A21	1/O	AOE
137	A21 A20	1/O	AOE
130	A20 A19	1/O	AOE
108	AIS	1/0	AUE

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Bit Number	Bit/Pin Name	Bit/Pin Type	Output Enable
140	A18	I/O	AOE
141	A17	I/O	AOE
142	A16	I/O	AOE
143	A15	I/O	AOE
144	A14	I/O	AOE
145	A13	I/O	AOE
146	TSIZ2	I/O	AOE
147	TSIZ0	I/O	AOE
148	TSIZ1	I/O	AOE
149	GBL	Output	AOE
150	CFG3	Input	
151	L2 CI	Input	
152	L2 FLUSH	Input	
153	AP0	I/O	AOE
154	AP1	I/O	AOE
155	AP2	I/O	AOE
156	AP3	I/O	AOE
157	APE	Output	APEOE
158	TAOE	Output Enable	
159	L2CLAIMOE	Output Enable	
160	L2BROE	Output Enable	

# 6. PREPARATION FOR DELIVERY

# 6.1. Packaging

Microcircuits are prepared for delivery in accordance with MIL-PRF-38535.

# 6.2. Certificate of compliance

TCS offers a certificate of compliances with each shipment of parts, affirming the products are in compliance either with MIL-STD-883 and guarantying the parameters not tested at temperature extremes for the entire temperature range.

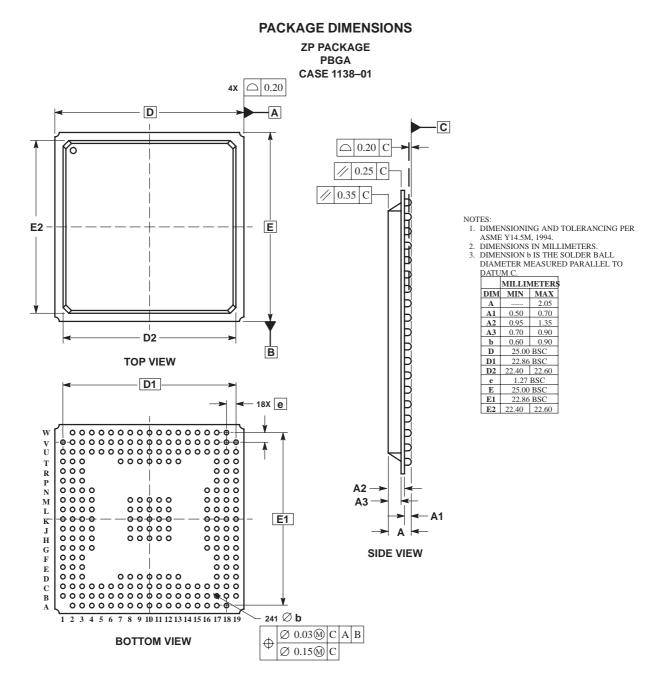
# 7. HANDLING

MOS devices must be handled with certain precautions to avoid damage due to accumulation of static charge. Input protection devices have been designed in the chip to minimize the effect of this static buildup. However, the following handling practices are recommended :

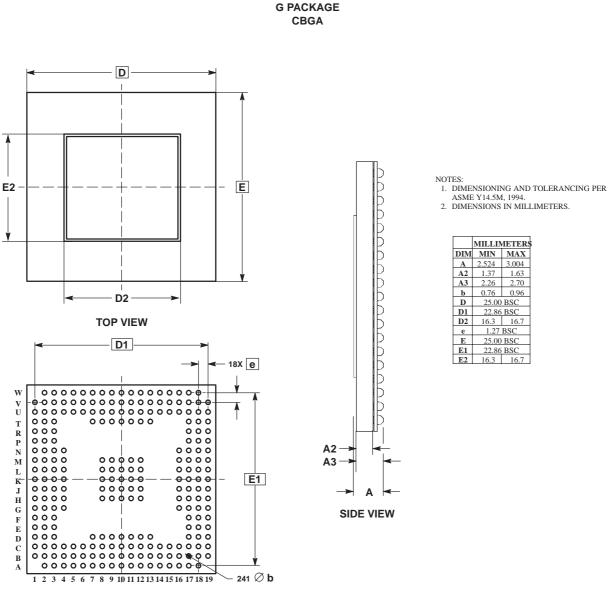
- a) Devices should be handled on benches with conductive and grounded surfaces.
- b) Ground test equipment, tools and operator.
- c) Do not handle devices by the leads.
- d) Store devices in conductive foam or carriers.
- e) Avoid use of plastic, rubber, or silk in MOS areas.
- f) Maintain relative humidity above 50 percent if practical.

# 8. PACKAGE MECHANICAL DATA

#### 8.1. 241 pins - PBGA



#### 8.2. 241 pins - CBGA (To Be Confirmed)

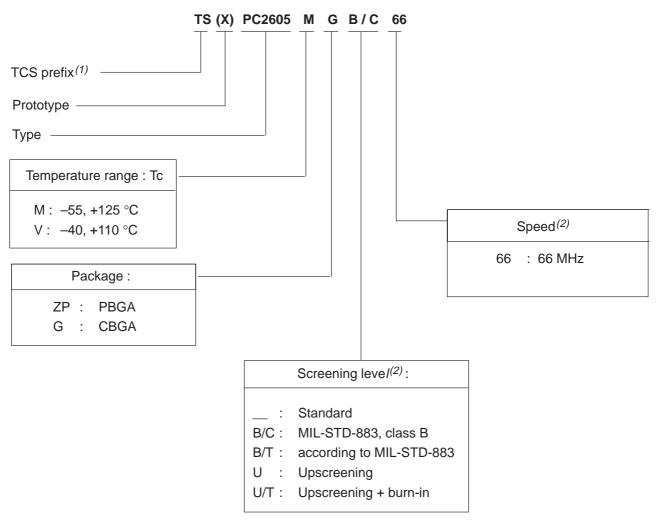


**PACKAGE DIMENSIONS** 

**BOTTOM VIEW** 

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# 9. ORDERING INFORMATION



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(2) For availability of the different versions, contact your TCS sale office

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